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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

Details

Product Status	Active
Number of LABs/CLBs	-
Number of Logic Elements/Cells	-
Total RAM Bits	2560
Number of I/O	176
Number of Gates	54000
Voltage - Supply	3V ~ 3.6V, 4.5V ~ 5.5V
Mounting Type	Surface Mount
Operating Temperature	-55°C ~ 125°C (TJ)
Package / Case	208-BFCQFP with Tie Bar
Supplier Device Package	208-CQFP (75x75)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/a42mx36-cq208b

Figures

Figure 1	Ordering Information	3
Figure 2	42MX C-Module Implementation	7
Figure 3	42MX C-Module Implementation	7
Figure 4	42MX S-Module Implementation	8
Figure 5	A42MX24 and A42MX36 D-Module Implementation	9
Figure 6	A42MX36 Dual-Port SRAM Block	9
Figure 7	MX Routing Structure	10
Figure 8	Clock Networks of 42MX Devices	11
Figure 9	Quadrant Clock Network of A42MX36 Devices	11
Figure 10	42MX I/O Module	12
Figure 11	PCI Output Structure of A42MX24 and A42MX36 Devices	12
Figure 12	Silicon Explorer II Setup with 40MX	16
Figure 13	Silicon Explorer II Setup with 42MX	17
Figure 14	42MX IEEE 1149.1 Boundary Scan Circuitry	18
Figure 15	Device Selection Wizard	19
Figure 16	Typical Output Drive Characteristics (Based Upon Measured Data)	28
Figure 17	40MX Timing Model*	30
Figure 18	42MX Timing Model	30
Figure 19	42MX Timing Model (Logic Functions Using Quadrant Clocks)	31
Figure 20	42MX Timing Model (SRAM Functions)	32
Figure 21	Output Buffer Delays	32
Figure 22	AC Test Loads	33
Figure 23	Input Buffer Delays	33
Figure 24	Module Delays	33
Figure 25	Flip-Flops and Latches	34
Figure 26	Input Buffer Latches	34
Figure 27	Output Buffer Latches	35
Figure 28	Decode Module Timing	35
Figure 29	SRAM Timing Characteristics	35
Figure 30	42MX SRAM Write Operation	36
Figure 31	42MX SRAM Synchronous Read Operation	36
Figure 32	42MX SRAM Asynchronous Read Operation—Type 1 (Read Address Controlled)	36
Figure 33	42MX SRAM Asynchronous Read Operation—Type 2 (Write Address Controlled)	37
Figure 34	42MX Junction Temperature and Voltage Derating Curves (Normalized to $T_J = 25^\circ\text{C}$, $VCCA = 5.0\text{ V}$)	38
Figure 35	40MX Junction Temperature and Voltage Derating Curves (Normalized to $T_J = 25^\circ\text{C}$, $VCC = 5.0\text{ V}$)	39
Figure 36	42MX Junction Temperature and Voltage Derating Curves (Normalized to $T_J = 25^\circ\text{C}$, $VCCA = 3.3\text{ V}$)	39
Figure 37	40MX Junction Temperature and Voltage Derating Curves (Normalized to $T_J = 25^\circ\text{C}$, $VCC = 3.3\text{ V}$)	40
Figure 38	PL44	86
Figure 39	PL68	88
Figure 40	PL84	90
Figure 41	PQ100	93
Figure 42	PQ144	97
Figure 43	PQ160	102
Figure 44	PQ208	107
Figure 45	PQ240	113
Figure 46	VQ80	120
Figure 47	VQ100	123
Figure 48	TQ176	126
Figure 49	CQ208	131
Figure 50	CQ256	138

1 Revision History

The revision history describes the changes that were implemented in the document. The changes are listed by revision, starting with the most current publication.

1.1 Revision 15.0

The following is a summary of the changes in revision 15.0 of this document.

- Table 15, page 21 is edited to add the footnote, VIH(Min) is 2.4V for A42MX36 family. This applies only to VCCI of 5V and is not applicable to VCCI of 3.3V
- Table 22, page 25 is edited to add the footnote, VIH(Min) is 2.4V for A42MX36 family. This applies only to VCCI of 5V and is not applicable to VCCI of 3.3V
- Table 23, page 25 is edited to add the footnote, VIH(Min) is 2.4V for A42MX36 family. This applies only to VCCI of 5V and is not applicable to VCCI of 3.3V

1.2 Revision 14.0

The following is a summary of the changes in revision 14.0 of this document.

- Added CQFP package information for A42MX16 device in Product Profile, page 1 and Ceramic Device Resources, page 4 (SAR 79522).
- Added Military (M) and MIL-STD-883 Class B (B) grades for CPGA 132 Package and added Commercial (C), Military (M), and MIL-STD-883 Class B (B) grades for CQFP 172 Package in Temperature Grade Offerings, page 5 (SAR 79519)
- Changed Silicon Sculptor II to Silicon Sculptor in Programming, page 12 (SAR 38754)
- Added Figure 53, page 158 CQ172 package (SAR 79522).

1.3 Revision 13.0

The following is a summary of the changes in revision 13.0 of this document.

- Added Figure 42, page 97 PQ144 Package for A42MX09 device (SAR 69776)
- Added Figure 52, page 153 PQ132 Package for A42MX09 device (SAR 69776)

1.4 Revision 12.0

The following is a summary of the changes in revision 12.0 of this document.

- Added information on power-up behavior for A42MX24 and A42MX36 devices to the Power Supply, page 13 (SAR 42096)
- Corrected the inadvertent mistake in the naming of the PL68 pin assignment table (SARs 48999, 49793)

1.5 Revision 11.0

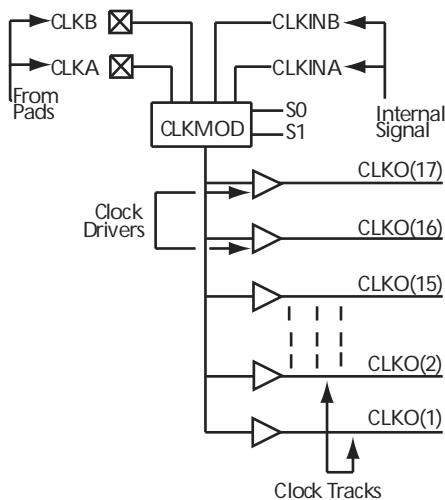
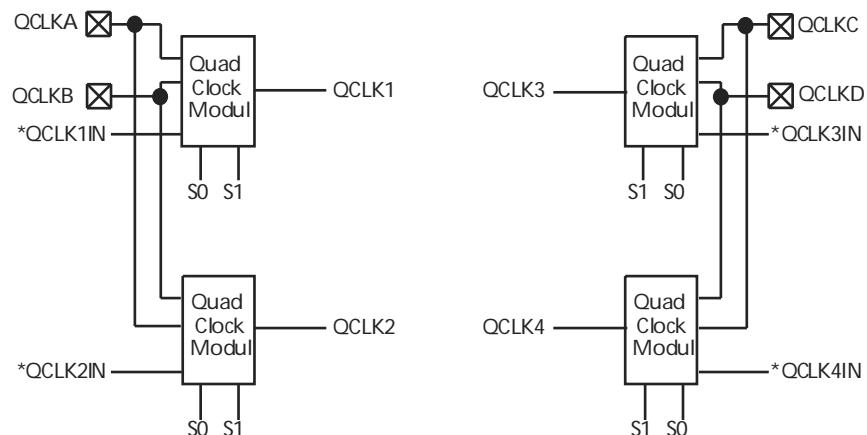
The following is a summary of the changes in revision 11.0 of this document.

- The FuseLock logo and accompanying text was removed from the User Security, page 12. This marking is no longer used on Microsemi devices (PCN 0915)
- The Development Tool Support, page 19 was updated (SAR 38512)

1.6 Revision 10.0

The following is a summary of the changes in revision 10.0 of this document.

- Ordering Information, page 3 was updated to include lead-free package ordering codes (SAR 21968)
- The User Security, page 12 was revised to clarify that although no existing security measures can give an absolute guarantee, Microsemi FPGAs implement the best security available in the industry (SAR 34673)

Figure 8 • Clock Networks of 42MX Devices**Figure 9 • Quadrant Clock Network of A42MX36 Devices**

Note: *QCLK1IN, QCLK2IN, QCLK3IN, and QCLK4IN are internally-generated signals.

3.2.5 MultiPlex I/O Modules

42MX devices feature Multiplex I/Os and support 5.0 V, 3.3 V, and mixed 3.3 V/5.0 V operations.

The MultiPlex I/O modules provide the interface between the device pins and the logic array. Figure 10, page 12 is a block diagram of the 42MX I/O module. A variety of user functions, determined by a library macro selection, can be implemented in the module. (See the *Antifuse Macro Library Guide* for more information.) All 42MX I/O modules contain tristate buffers, with input and output latches that can be configured for input, output, or bidirectional operation.

All 42MX devices contain flexible I/O structures, where each output pin has a dedicated output-enable control (Figure 10, page 12). The I/O module can be used to latch input or output data, or both, providing fast set-up time. In addition, the Designer software tools can build a D-type flip-flop using a C-module combined with an I/O module to register input and output signals. See the *Antifuse Macro Library Guide* for more details.

A42MX24 and A42MX36 devices also offer selectable PCI output drives, enabling 100% compliance with version 2.1 of the PCI specification. For low-power systems, all inputs and outputs are turned off to reduce current consumption to below 500 μ A.

To achieve 5.0 V or 3.3 V PCI-compliant output drives on A42MX24 and A42MX36 devices, a chip-wide PCI fuse is programmed via the Device Selection Wizard in the Designer software (Figure 11, page 12). When the PCI fuse is not programmed, the output drive is standard.

3.4.9 JTAG Mode Activation

The JTAG test logic circuit is activated in the Designer software by selecting **Tools > Device Selection**. This brings up the Device Selection dialog box as shown in the following figure. The JTAG test logic circuit can be enabled by clicking the “Reserve JTAG Pins” check box. The following table explains the pins’ behavior in either mode.

Figure 15 • Device Selection Wizard

Table 11 • Boundary Scan Pin Configuration and Functionality

Reserve JTAG	Checked	Unchecked
TCK	BST input; must be terminated to logical HIGH or LOW to avoid floating	User I/O
TDI, TMS	BST input; may float or be tied to HIGH	User I/O
TDO	BST output; may float or be connected to TDI of another device	User I/O

3.4.10 TRST Pin and TAP Controller Reset

An active reset (TRST) pin is not supported; however, MX devices contain power-on circuitry that resets the boundary scan circuitry upon power-up. Also, the TMS pin is equipped with an internal pull-up resistor. This allows the TAP controller to remain in or return to the Test-Logic-Reset state when there is no input or when a logical 1 is on the TMS pin. To reset the controller, TMS must be HIGH for at least five TCK cycles.

3.4.11 Boundary Scan Description Language (BSDL) File

Conforming to the IEEE Standard 1149.1 requires that the operation of the various JTAG components be documented. The BSDL file provides the standard format to describe the JTAG components that can be used by automatic test equipment software. The file includes the instructions that are supported, instruction bit pattern, and the boundary-scan chain order. For an in-depth discussion on BSDL files, see the *BSDL Files Format Description* application note.

BSDL files are grouped into two categories - generic and device-specific. The generic files assign all user I/Os as inouts. Device-specific files assign user I/Os as inputs, outputs or inouts.

Generic files for MX devices are available on the Microsemi SoC Product Group's website:

<http://www.microsemi.com/soc/techdocs/models/bsdl.html>.

3.5 Development Tool Support

The MX family of FPGAs is fully supported by Libero® Integrated Design Environment (IDE). Libero IDE is a design management environment, seamlessly integrating design tools while guiding the user through the design flow, managing all design and log files, and passing necessary design data among tools.

Libero IDE allows users to integrate both schematic and HDL synthesis into a single flow and verify the entire design in a single environment. Libero IDE includes SynplifyPro from Synopsys, ModelSim® HDL Simulator from Mentor Graphics® and Viewdraw.

Libero IDE includes place-and-route and provides a comprehensive suite of backend support tools for FPGA development, including timing-driven place-and-route, and a world-class integrated static timing analyzer and constraints editor.

3.9.3 Output Drive Characteristics for 3.3 V PCI Signaling

Table 25 • DC Specification (3.3 V PCI Signaling)¹

Symbol	Parameter	Condition	PCI		MX		Units
			Min.	Max.	Min.	Max.	
VCCI	Supply Voltage for I/Os		3.0	3.6	3.0	3.6 ²	V
VIH	Input High Voltage		0.5	VCC + 0.5	0.5	VCCI + 0.3	V
VIL	Input Low Voltage		-0.5	0.8	-0.3	0.8	V
I _{IH}	Input High Leakage Current	VIN = 2.7 V		70		10	µA
I _{IL}	Input Leakage Current			-70		-10	µA
V _{OH}	Output High Voltage	I _{OUT} = -2 mA	0.9		3.3		V
V _{OL}	Output Low Voltage	I _{OUT} = 3 mA, 6 mA		0.1		0.1 VCCI	V
C _{IN}	Input Pin Capacitance			10		10	pF
C _{CLK}	CLK Pin Capacitance		5	12		10	pF
L _{PIN}	Pin Inductance			20		< 8 nH ³	nH

1. PCI Local Bus Specification, Version 2.1, Section 4.2.2.1.

2. Maximum rating for VCCI -0.5 V to 7.0V.

3. Dependent upon the chosen package. PCI recommends QFP and BGA packaging to reduce pin inductance and capacitance.

Table 26 • AC Specifications for (3.3 V PCI Signaling)^{*}

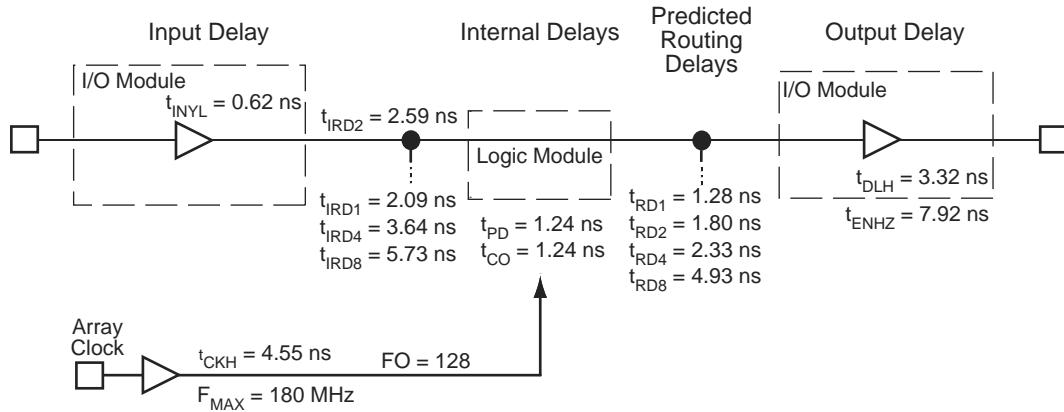
Symbol	Parameter	Condition	PCI		MX		Units
			Min.	Max.	Min.	Max.	
I _{CL}	Low Clamp Current	-5 < VIN ≤ -1	-25 + (VIN +1) /0.015		-60	-10	mA
Slew (r)	Output Rise Slew Rate	0.2 V to 0.6 V load	1		4	1.8	V/ns
Slew (f)	Output Fall Slew Rate	0.6 V to 0.2 V load	1		4	2.8	4.0
							V/ns

Note: *PCI Local Bus Specification, Version 2.1, Section 4.2.2.2.

3.10 Timing Models

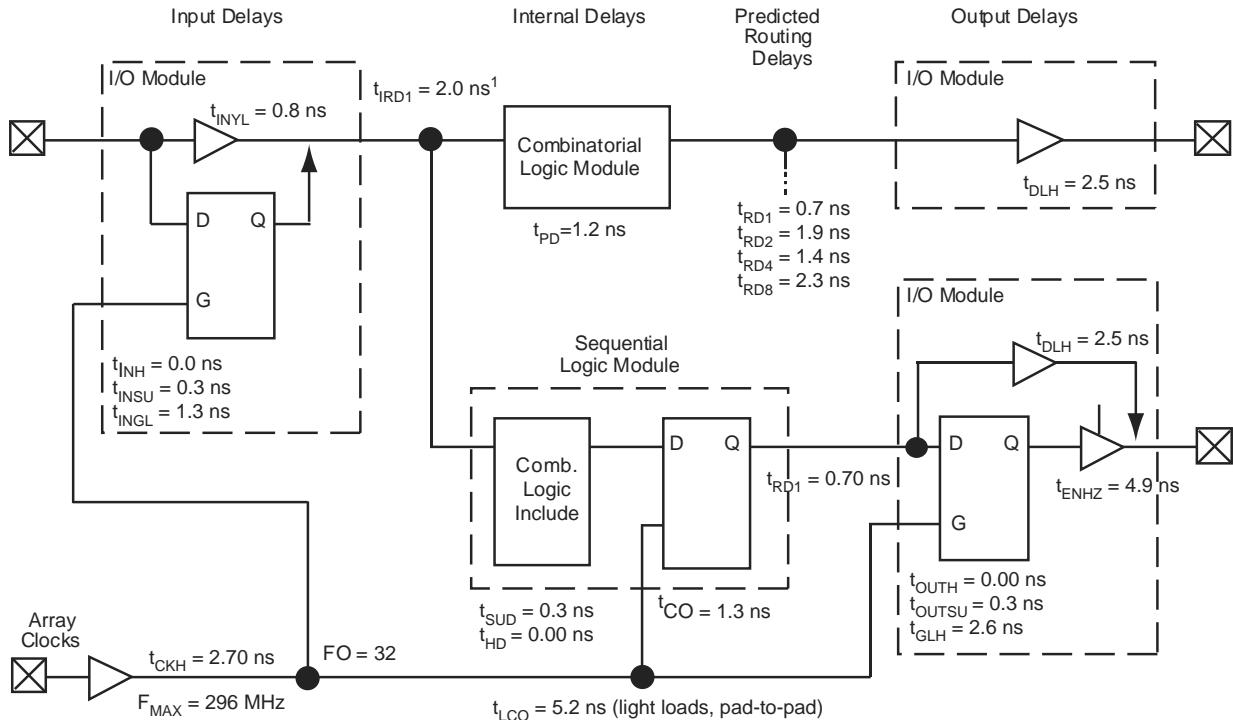
The following figures show various timing models.

Figure 17 • 40MX Timing Model*



Note: Values are shown for 40MX –3 speed devices at 5.0 V worst-case commercial conditions.

Figure 18 • 42MX Timing Model



Note: 1. Input module predicted routing delay

Note: 2. Values are shown for A42MX09 –3 at 5.0 V worst-case commercial conditions.

Table 34 • A40MX02 Timing Characteristics (Nominal 5.0 V Operation) (continued)
(Worst-Case Commercial Conditions, VCC = 4.75 V, TJ = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
TTL Output Module Timing⁴											
t _{DLH}	Data-to-Pad HIGH	3.3	3.8	4.3	5.1	7.2	ns				
t _{DHL}	Data-to-Pad LOW	4.0	4.6	5.2	6.1	8.6	ns				
t _{ENZH}	Enable Pad Z to HIGH	3.7	4.3	4.9	5.8	8.0	ns				
t _{ENZL}	Enable Pad Z to LOW	4.7	5.4	6.1	7.2	10.1	ns				
t _{ENHZ}	Enable Pad HIGH to Z	7.9	9.1	10.4	12.2	17.1	ns				
t _{ENLZ}	Enable Pad LOW to Z	5.9	6.8	7.7	9.0	12.6	ns				
d _{TLH}	Delta LOW to HIGH	0.02	0.02	0.03	0.03	0.04	ns/pF				
d _{THL}	Delta HIGH to LOW	0.03	0.03	0.03	0.04	0.06	ns/pF				
CMOS Output Module Timing⁴											
t _{DLH}	Data-to-Pad HIGH	3.9	4.5	5.1	6.05	8.5	ns				
t _{DHL}	Data-to-Pad LOW	3.4	3.9	4.4	5.2	7.3	ns				
t _{ENZH}	Enable Pad Z to HIGH	3.4	3.9	4.4	5.2	7.3	ns				
t _{ENZL}	Enable Pad Z to LOW	4.9	5.6	6.4	7.5	10.5	ns				
t _{ENHZ}	Enable Pad HIGH to Z	7.9	9.1	10.4	12.2	17.0	ns				
t _{ENLZ}	Enable Pad LOW to Z	5.9	6.8	7.7	9.0	12.6	ns				
d _{TLH}	Delta LOW to HIGH	0.03	0.04	0.04	0.05	0.07	ns/pF				
d _{THL}	Delta HIGH to LOW	0.02	0.02	0.03	0.03	0.04	ns/pF				

1. Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance
2. Set-up times assume fanout of 3. Further testing information can be obtained from the Timer utility
3. The hold time for the DFME1A macro may be greater than 0 ns. Use the Timer tool from the Designer software to check the hold time for this macro.
4. Delays based on 35pF loading

Table 35 • A40MX02 Timing Characteristics (Nominal 3.3 V Operation)
(Worst-Case Commercial Conditions, VCC = 3.0 V, TJ = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Logic Module Propagation Delays											
t _{PD1}	Single Module	1.7	2.0	2.3	2.7	3.7	ns				
t _{PD2}	Dual-Module Macros	3.7	4.3	4.9	5.7	8.0	ns				
t _{CO}	Sequential Clock-to-Q	1.7	2.0	2.3	2.7	3.7	ns				
t _{GO}	Latch G-to-Q	1.7	2.0	2.3	2.7	3.7	ns				
t _{RS}	Flip-Flop (Latch) Reset-to-Q	1.7	2.0	2.3	2.7	3.7	ns				
Logic Module Predicted Routing Delays¹											

Table 39 • A42MX09 Timing Characteristics (Nominal 3.3 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 3.0 V, TJ = 70°C)

Parameter / Description		-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
t _{RD4}	FO = 4 Routing Delay			1.9		2.1		2.4		2.9		4.0 ns
t _{RD8}	FO = 8 Routing Delay			3.2		3.6		4.1		4.8		6.7 ns
Logic Module Sequential Timing^{3, 4}												
t _{SUD}	Flip-Flop (Latch) Data Input Set-Up	0.5		0.5		0.6		0.7		0.9		ns
t _{HD}	Flip-Flop (Latch) Data Input Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{SUENA}	Flip-Flop (Latch) Enable Set-Up	0.6		0.6		0.7		0.8		1.2		ns
t _{HENA}	Flip-Flop (Latch) Enable Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse Width		4.7		5.3		6.0		7.0		9.8	ns
t _{WASYN}	Flip-Flop (Latch) Asynchronous Pulse Width		6.2		6.9		7.8		9.2		12.9	ns
t _A	Flip-Flop Clock Input Period	5.0		5.6		6.2		7.1		9.9		ns
t _{INH}	Input Buffer Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{NSU}	Input Buffer Latch Set-Up	0.3		0.3		0.3		0.4		0.6		ns
t _{OUTH}	Output Buffer Latch Hold	0.0		0.0		0.0		0.0		0.0		ns
t _{OUTSU}	Output Buffer Latch Set-Up	0.3		0.3		0.3		0.4		0.6		ns
f _{MAX}	Flip-Flop (Latch) Clock Frequency		161		146		135		117		70	MHz

Table 40 • A42MX16 Timing Characteristics (Nominal 5.0 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 4.75 V, TJ = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
t _{RD3}	FO = 3 Routing Delay		1.3		1.4		1.6		1.9		2.7 ns
t _{RD4}	FO = 4 Routing Delay		1.6		1.7		2.0		2.3		3.2 ns
t _{RD8}	FO = 8 Routing Delay		2.6		2.9		3.2		3.8		5.3 ns
Logic Module Sequential Timing^{3,4}											
t _{SUD}	Flip-Flop (Latch) Data Input Set-Up		0.3		0.4		0.4		0.5		0.7 ns
t _{HD}	Flip-Flop (Latch) Data Input Hold	0.0		0.0		0.0		0.0		0.0	ns
t _{SUENA}	Flip-Flop (Latch) Enable Set-Up	0.7		0.8		0.9		1.0		1.4	ns
t _{HENA}	Flip-Flop (Latch) Enable Hold	0.0		0.0		0.0		0.0		0.0	ns
t _{WCLKA}	Flip-Flop (Latch) Clock Active Pulse Width	3.4		3.8		4.3		5.0		7.1	ns
t _{WASYN}	Flip-Flop (Latch) Asynchronous Pulse Width	4.5		5.0		5.6		6.6		9.2	ns
t _A	Flip-Flop Clock Input Period	6.8		7.6		8.6		10.1		14.1	ns
t _{INH}	Input Buffer Latch Hold	0.0		0.0		0.0		0.0		0.0	ns
t _{INSU}	Input Buffer Latch Set-Up	0.5		0.5		0.6		0.7		1.0	ns
t _{OUTH}	Output Buffer Latch Hold	0.0		0.0		0.0		0.0		0.0	ns
t _{OUTSU}	Output Buffer Latch Set-Up	0.5		0.5		0.6		0.7		1.0	ns
f _{MAX}	Flip-Flop (Latch) Clock Frequency	215		195		179		156		94	MHz
Input Module Propagation Delays											
t _{INYH}	Pad-to-Y HIGH		1.1		1.2		1.3		1.6		2.2 ns
t _{INYL}	Pad-to-Y LOW		0.8		0.9		1.0		1.2		1.7 ns
t _{INGH}	G to Y HIGH		1.4		1.6		1.8		2.1		2.9 ns
t _{INGL}	G to Y LOW		1.4		1.6		1.8		2.1		2.9 ns
Input Module Predicted Routing Delays²											
t _{IRD1}	FO = 1 Routing Delay		1.8		2.0		2.3		2.7		4.0 ns
t _{IRD2}	FO = 2 Routing Delay		2.1		2.3		2.6		3.1		4.3 ns
t _{IRD3}	FO = 3 Routing Delay		2.3		2.6		3.0		3.5		4.9 ns
t _{IRD4}	FO = 4 Routing Delay		2.6		3.0		3.3		3.9		5.4 ns
t _{IRD8}	FO = 8 Routing Delay		3.6		4.0		4.6		5.4		7.5 ns
Global Clock Network											
t _{CKH}	Input LOW to HIGH	FO = 32	2.6		2.9		3.3		3.9		5.4 ns
		FO = 384	2.9		3.2		3.6		4.3		6.0 ns
t _{CKL}	Input HIGH to LOW	FO = 32	3.8		4.2		4.8		5.6		7.8 ns
		FO = 384	4.5		5.0		5.6		6.6		9.2 ns
t _{PWH}	Minimum Pulse Width HIGH	FO = 32	3.2		3.5		4.0		4.7		6.6 ns
		FO = 384	3.7		4.1		4.6		5.4		7.6 ns

Table 42 • A42MX24 Timing Characteristics (Nominal 5.0 V Operation) (continued)(Worst-Case Commercial Conditions, VCCA = 4.75 V, T_J = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
CMOS Output Module Timing⁵											
t _{DH}	Data-to-Pad HIGH		3.1		3.5		3.9		4.6		6.4 ns
t _{DHL}	Data-to-Pad LOW		2.4		2.6		3.0		3.5		4.9 ns
t _{ENZH}	Enable Pad Z to HIGH		2.5		2.8		3.2		3.8		5.3 ns
t _{ENZL}	Enable Pad Z to LOW		2.8		3.1		3.5		4.2		5.8 ns
t _{ENHZ}	Enable Pad HIGH to Z		5.2		5.7		6.5		7.6		10.7 ns
t _{ENLZ}	Enable Pad LOW to Z		4.8		5.3		6.0		7.1		9.9 ns
t _{GLH}	G-to-Pad HIGH		4.9		5.4		6.2		7.2		10.1 ns
t _{GHL}	G-to-Pad LOW		4.9		5.4		6.2		7.2		10.1 ns
t _{LSU}	I/O Latch Set-Up	0.5		0.5		0.6		0.7		1.0	ns
t _{LH}	I/O Latch Hold	0.0		0.0		0.0		0.0		0.0	ns
t _{LCO}	I/O Latch Clock-to-Out (Pad-to-Pad) 32 I/O		5.5		6.1		6.9		8.1		11.3 ns
t _{ACO}	Array Latch Clock-to-Out (Pad-to-Pad) 32 I/O		10.6		11.8		13.4		15.7		22.0 ns
d _{TLH}	Capacitive Loading, LOW to HIGH	0.04		0.04		0.04		0.05		0.07	ns/pF
d _{THL}	Capacitive Loading, HIGH to LOW	0.03		0.03		0.03		0.04		0.06	ns/pF

- For dual-module macros, use t_{PD1} + t_{RD1} + t_{PDn}, t_{CO} + t_{RD1} + t_{PDn}, or t_{PD1} + t_{RD1} + t_{SUD}, whichever is appropriate.
- Routing delays are for typical designs across worst-case operating conditions. These parameters should be used for estimating device performance. Post-route timing analysis or simulation is required to determine actual performance.
- Data applies to macros based on the S-module. Timing parameters for sequential macros constructed from C-modules can be obtained from the Timer utility.
- Set-up and hold timing parameters for the Input Buffer Latch are defined with respect to the PAD and the D input. External setup/hold timing parameters must account for delay from an external PAD signal to the G inputs. Delay from an external PAD signal to the G input subtracts (adds) to the internal setup (hold) time.
- Delays based on 35 pF loading

Table 43 • A42MX24 Timing Characteristics (Nominal 3.3 V Operation) (Worst-Case Commercial Conditions, VCCA = 3.0 V, T_J = 70°C)

Parameter / Description	-3 Speed		-2 Speed		-1 Speed		Std Speed		-F Speed		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
Logic Module Combinatorial Functions¹											
t _{PD}	Internal Array Module Delay	2.0		1.8		2.1		2.5		3.4	ns
t _{PDD}	Internal Decode Module Delay	1.1		2.2		2.5		3.0		4.2	ns
Logic Module Predicted Routing Delays²											
t _{RD1}	FO = 1 Routing Delay	1.7		1.3		1.4		1.7		2.3	ns
t _{RD2}	FO = 2 Routing Delay	2.0		1.6		1.8		2.1		3.0	ns
t _{RD3}	FO = 3 Routing Delay	1.1		2.0		2.2		2.6		3.7	ns
t _{RD4}	FO = 4 Routing Delay	1.5		2.3		2.6		3.1		4.3	ns
t _{RD5}	FO = 8 Routing Delay	1.8		3.7		4.2		5.0		7.0	ns

Clock signal to shift the Boundary Scan Test (BST) data into the device. This pin functions as an I/O when "Reserve JTAG" is not checked in the Designer Software. BST pins are only available in A42MX24 and A42MX36 devices.

TDI, I/OTest Data In

Serial data input for BST instructions and data. Data is shifted in on the rising edge of TCK. This pin functions as an I/O when "Reserve JTAG" is not checked in the Designer Software. BST pins are only available in A42MX24 and A42MX36 devices.

TDO, I/OTest Data Out

Serial data output for BST instructions and test data. This pin functions as an I/O when "Reserve JTAG" is not checked in the Designer Software. BST pins are only available in A42MX24 and A42MX36 devices.

TMS, I/OTest Mode Select

The TMS pin controls the use of the IEEE 1149.1 Boundary Scan pins (TCK, TDI, TDO). In flexible mode when the TMS pin is set LOW, the TCK, TDI and TDO pins are boundary scan pins. Once the boundary scan pins are in test mode, they will remain in that mode until the internal boundary scan state machine reaches the "logic reset" state. At this point, the boundary scan pins will be released and will function as regular I/O pins. The "logic reset" state is reached 5 TCK cycles after the TMS pin is set HIGH. In dedicated test mode, TMS functions as specified in the IEEE 1149.1 specifications. IEEE JTAG specification recommends a 10kΩ pull-up resistor on the pin. BST pins are only available in A42MX24 and A42MX36 devices.

VCC, Supply Voltage

Input supply voltage for 40MX devices

VCCA, Supply Voltage

Supply voltage for array in 42MX devices

VCCI, Supply Voltage

Supply voltage for I/Os in 42MX devices

WD, IOWide Decode Output

When a wide decode module is used in a 42MX device this pin can be used as a dedicated output from the wide decode module. This direct connection eliminates additional interconnect delays associated with regular logic modules. To implement the direct I/O connection, connect an output buffer of any type to the output of the wide decode macro and place this output on one of the reserved WD pins.

Table 49 • PL84

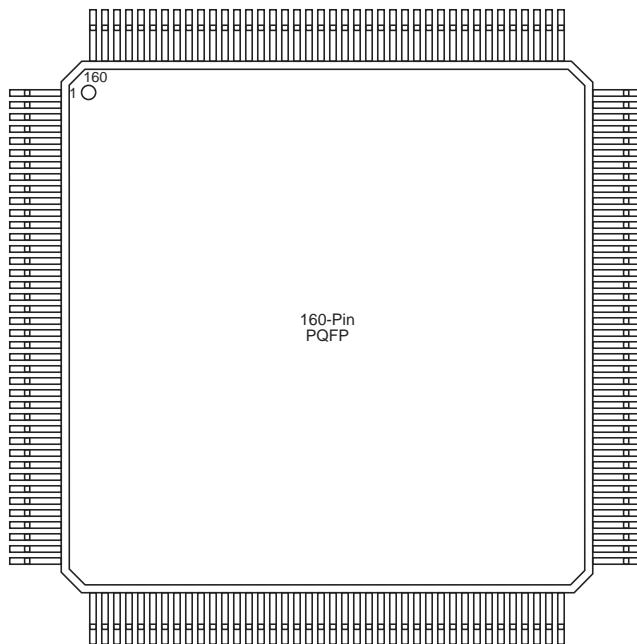
PL84	Pin Number	A40MX04 Function	A42MX09 Function	A42MX16 Function	A42MX24 Function
10	I/O		DCLK, I/O	DCLK, I/O	DCLK, I/O
11	I/O		I/O	I/O	I/O
12	NC		MODE	MODE	MODE
13	I/O		I/O	I/O	I/O
14	I/O		I/O	I/O	I/O
15	I/O		I/O	I/O	I/O
16	I/O		I/O	I/O	I/O
17	I/O		I/O	I/O	I/O
18	GND		I/O	I/O	I/O
19	GND		I/O	I/O	I/O
20	I/O		I/O	I/O	I/O
21	I/O		I/O	I/O	I/O
22	I/O		VCCA	VCCI	VCCI
23	I/O		VCCI	VCCA	VCCA
24	I/O		I/O	I/O	I/O
25	VCC		I/O	I/O	I/O
26	VCC		I/O	I/O	I/O
27	I/O		I/O	I/O	I/O
28	I/O		GND	GND	GND
29	I/O		I/O	I/O	I/O
30	I/O		I/O	I/O	I/O
31	I/O		I/O	I/O	I/O
32	I/O		I/O	I/O	I/O
33	VCC		I/O	I/O	I/O
34	I/O		I/O	I/O	TMS, I/O
35	I/O		I/O	I/O	TDI, I/O
36	I/O		I/O	I/O	WD, I/O
37	I/O		I/O	I/O	I/O
38	I/O		I/O	I/O	WD, I/O
39	I/O		I/O	I/O	WD, I/O
40	GND		I/O	I/O	I/O
41	I/O		I/O	I/O	I/O
42	I/O		I/O	I/O	I/O
43	I/O		VCCA	VCCA	VCCA
44	I/O		I/O	I/O	WD, I/O
45	I/O		I/O	I/O	WD, I/O
46	VCC		I/O	I/O	WD, I/O

Table 50 • PQ 100

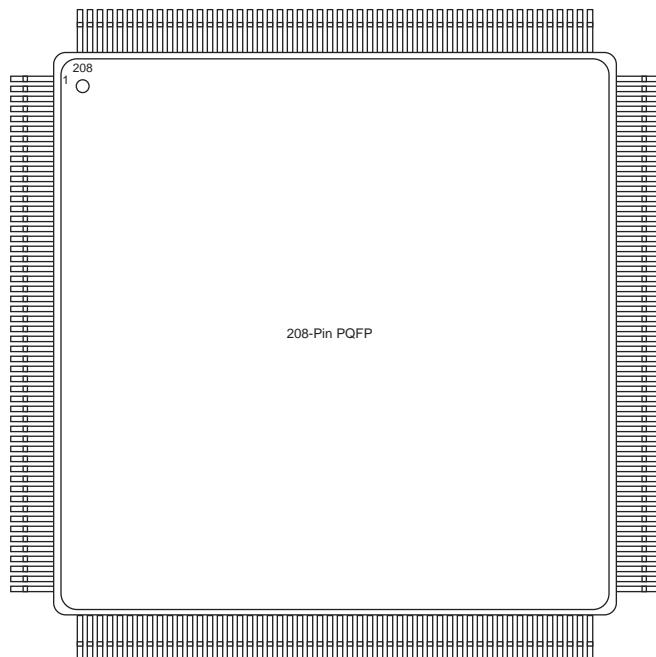
PQ100	Pin Number	A40MX02 Function	A40MX04 Function	A42MX09 Function	A42MX16 Function
19	VCC	V _{CC}		I/O	I/O
20	I/O	I/O		I/O	I/O
21	I/O	I/O		I/O	I/O
22	I/O	I/O	GND		GND
23	I/O	I/O		I/O	I/O
24	I/O	I/O		I/O	I/O
25	I/O	I/O		I/O	I/O
26	I/O	I/O		I/O	I/O
27	NC	NC		I/O	I/O
28	NC	NC		I/O	I/O
29	NC	NC		I/O	I/O
30	NC	NC		I/O	I/O
31	NC	I/O		I/O	I/O
32	NC	I/O		I/O	I/O
33	NC	I/O		I/O	I/O
34	I/O	I/O	GND		GND
35	I/O	I/O		I/O	I/O
36	GND	GND		I/O	I/O
37	GND	GND		I/O	I/O
38	I/O	I/O		I/O	I/O
39	I/O	I/O		I/O	I/O
40	I/O	I/O	VCCA		VCCA
41	I/O	I/O		I/O	I/O
42	I/O	I/O		I/O	I/O
43	VCC	VCC		I/O	I/O
44	VCC	VCC		I/O	I/O
45	I/O	I/O		I/O	I/O
46	I/O	I/O	GND		GND
47	I/O	I/O		I/O	I/O
48	NC	I/O		I/O	I/O
49	NC	I/O		I/O	I/O
50	NC	I/O		I/O	I/O
51	NC	NC		I/O	I/O
52	NC	NC	SDO, I/O		SDO, I/O
53	NC	NC		I/O	I/O
54	NC	NC		I/O	I/O
55	NC	NC		I/O	I/O

Table 51 • PQ144

PQ144	
Pin Number	A42MX09 Function
117	GNDI
118	NC
119	I/O
120	I/O
121	I/O
122	I/O
123	PROBA
124	I/O
125	CLKA
126	VCC
127	VCCI
128	NC
129	I/O
130	CLKB
131	I/O
132	PROBB
133	I/O
134	I/O
135	I/O
136	GND
137	GNDI
138	NC
139	I/O
140	I/O
141	I/O
142	I/O
143	I/O
144	DCLK

Figure 43 • PQ160**Table 52 • PQ160**

PQ160			
Pin Number	A42MX09 Function	A42MX16 Function	A42MX24 Function
1	I/O	I/O	I/O
2	DCLK, I/O	DCLK, I/O	DCLK, I/O
3	NC	I/O	I/O
4	I/O	I/O	WD, I/O
5	I/O	I/O	WD, I/O
6	NC	VCCI	VCCI
7	I/O	I/O	I/O
8	I/O	I/O	I/O
9	I/O	I/O	I/O
10	NC	I/O	I/O
11	GND	GND	GND
12	NC	I/O	I/O
13	I/O	I/O	WD, I/O
14	I/O	I/O	WD, I/O
15	I/O	I/O	I/O
16	PRB, I/O	PRB, I/O	PRB, I/O
17	I/O	I/O	I/O
18	CLKB, I/O	CLKB, I/O	CLKB, I/O
19	I/O	I/O	I/O
20	VCCA	VCCA	VCCA

Figure 44 • PQ208**Table 53 • PQ208**

PQ208	Pin Number	A42MX16 Function	A42MX24 Function	A42MX36 Function
	1	GND	GND	GND
	2	NC	VCCA	VCCA
	3	MODE	MODE	MODE
	4	I/O	I/O	I/O
	5	I/O	I/O	I/O
	6	I/O	I/O	I/O
	7	I/O	I/O	I/O
	8	I/O	I/O	I/O
	9	NC	I/O	I/O
	10	NC	I/O	I/O
	11	NC	I/O	I/O
	12	I/O	I/O	I/O
	13	I/O	I/O	I/O
	14	I/O	I/O	I/O
	15	I/O	I/O	I/O
	16	NC	I/O	I/O
	17	VCCA	VCCA	VCCA
	18	I/O	I/O	I/O
	19	I/O	I/O	I/O
	20	I/O	I/O	I/O

Table 54 • PQ240

PQ240	
Pin Number	A42MX36 Function
126	WD, I/O
127	I/O
128	VCCI
129	I/O
130	I/O
131	I/O
132	WD, I/O
133	WD, I/O
134	I/O
135	QCLKB, I/O
136	I/O
137	I/O
138	I/O
139	I/O
140	I/O
141	I/O
142	WD, I/O
143	WD, I/O
144	I/O
145	I/O
146	I/O
147	I/O
148	I/O
149	I/O
150	VCCI
151	VCCA
152	GND
153	I/O
154	I/O
155	I/O
156	I/O
157	I/O
158	I/O
159	WD, I/O
160	WD, I/O
161	I/O
162	I/O

Table 57 • TQ176

TQ176	Pin Number	A42MX09 Function	A42MX16 Function	A42MX24 Function
	121	NC	NC	I/O
	122	I/O	I/O	I/O
	123	I/O	I/O	I/O
	124	NC	I/O	I/O
	125	NC	I/O	I/O
	126	NC	NC	I/O
	127	I/O	I/O	I/O
	128	I/O	I/O	I/O
	129	I/O	I/O	I/O
	130	I/O	I/O	I/O
	131	I/O	I/O	I/O
	132	I/O	I/O	I/O
	133	GND	GND	GND
	134	I/O	I/O	I/O
	135	SDI, I/O	SDI, I/O	SDI, I/O
	136	NC	I/O	I/O
	137	I/O	I/O	WD, I/O
	138	I/O	I/O	WD, I/O
	139	I/O	I/O	I/O
	140	NC	VCCI	VCCI
	141	I/O	I/O	I/O
	142	I/O	I/O	I/O
	143	NC	I/O	I/O
	144	NC	I/O	WD, I/O
	145	NC	NC	WD, I/O
	146	I/O	I/O	I/O
	147	NC	I/O	I/O
	148	I/O	I/O	I/O
	149	I/O	I/O	I/O
	150	I/O	I/O	WD, I/O
	151	NC	I/O	WD, I/O
	152	PRA, I/O	PRA, I/O	PRA, I/O
	153	I/O	I/O	I/O
	154	CLKA, I/O	CLKA, I/O	CLKA, I/O
	155	VCCA	VCCA	VCCA
	156	GND	GND	GND
	157	I/O	I/O	I/O

Table 58 • CQ208

CQ208	
Pin Number	A42MX36 Function
111	I/O
112	I/O
113	I/O
114	I/O
115	I/O
116	I/O
117	I/O
118	I/O
119	I/O
120	I/O
121	I/O
122	I/O
123	I/O
124	I/O
125	I/O
126	GND
127	I/O
128	TCK, I/O
129	LP
130	VCCA
131	GND
132	VCCI
133	VCCA
134	I/O
135	I/O
136	VCCA
137	I/O
138	I/O
139	I/O
140	I/O
141	I/O
142	I/O
143	I/O
144	I/O
145	I/O
146	I/O
147	I/O

Table 60 • BG272

BG272	
Pin Number	A42MX36 Function
T19	I/O
T20	I/O
U1	I/O
U2	I/O
U3	I/O
U4	I/O
U5	VCCI
U6	WD, I/O
U7	I/O
U8	I/O
U9	WD, I/O
U10	VCCA
U11	VCCI
U12	I/O
U13	I/O
U14	QCLKB, I/O
U15	I/O
U16	VCCI
U17	I/O
U18	GND
U19	I/O
U20	I/O
V1	I/O
V2	I/O
V3	GND
V4	GND
V5	I/O
V6	I/O
V7	I/O
V8	WD, I/O
V9	I/O
V10	I/O
V11	I/O
V12	I/O
V13	WD, I/O
V14	I/O
V15	WD, I/O